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Sheet 1 of 1

ATTORNEY DOCKET NO.	SERIAL NO.
9319S-000656	To be assigned
APPLICANT	
Osamu SHINKAWA	
FILING DATE	GROUP
Herewith	To be assigned

U.S. PATENT DOCUMENTS							
						(If appropriate) Filing Date	
1.							

FOREIGN PATENT DOCUMENTS								
Ref. Desig.	Examiner's Initials	Document Number	Date	Country		Class/ Subclass	Translation Yes	n* No
1.	JL	08-309963	11/26/1996	Japan			×	

OTHE	OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)					
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Sheet 1 of 2

ATTORNEY DOCKET No.	SERIAL NO.
9319S-000656	10/789,940
APPLICANT	
Osamu Shinkawa	
FILING DATE	GROUP
February 27, 2004	2861

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FORE	IGN PATEN	IT DOCUMENTS				
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation * Yes No
1.	JĻ	63-141750	6/14/1988	Japan		Abstract
2.	JL	11-334102	12/7/1999	Japan		х
3.	JL	02-003323	1/8/1990	Japan		Abstract
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2.			1	Communication from JPO re: related PCT application No. PCT/JP2004/002403.
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5.				Communication from JPO re: related PCT application No. PCT/JP2004/002400.
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Examiner:	/Jannelle Lebron/	Date Considered:	05/11/2006



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Sheet 1 of 1

SERIAL NO.	
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GROUP	
2861	
	10/789,940 GROUP

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2.	JL	6,375,299	4/23/2002	Foster et al		
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3.	JL	EP 0 933 215 A2	2/1/1999	Europe	1.	N/A	

OTHE	OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)				
Ref. Desig.	Examiner's Initials				
1.	JL	Communication from European Patent Office re: counterpart application			

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